



#### **DUAL N-CHANNEL ENHANCEMENT MODE MOSFET**

### **Product Summary**

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> max	I <sub>D</sub> max T <sub>A</sub> = +25°C
	$3\Omega @ V_{GS} = 4.5V$	250 mA
30V	5Ω @ V <sub>GS</sub> = 4.0V	200 mA
	7Ω @ V <sub>GS</sub> = 2.5V	100 mA

### **Description**

This MOSFET has been designed to minimize the on-state resistance (R<sub>DS(ON)</sub>) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

### **Applications**

- Motor Control
- Power Management Functions
- DC-DC Converters
- Backlighting





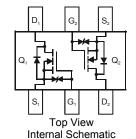
Top View

## **Features and Benefits**

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- ESD Protected Gate to 2kV
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 standards for High Reliability

#### **Mechanical Data**

- Case: SOT363
- Case Material: Molded Plastic, "Green" Molding Compound.
   UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See diagram
- Terminals: Finish Matte Tin annealed over Alloy42 leadframe.
   Solderable per MIL-STD-202, Method 208 (a)
- Weight: 0.006 grams (approximate)



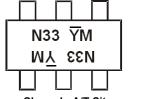
# Ordering Information (Note 4)

Part Number	Case	Packaging
DMN33D8LDW-7	SOT363	3K/Tape & Reel
DMN33D8LDW-13	SOT363	10K/Tape & Reel

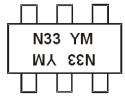
Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds
- 4. For packaging details, go to our website at http"//www.diodes.com/products/packages.html

## **Marking Information**



Chengdu A/T Site



Shanghai A/T Site

N33 = Product Type Marking Code

YM = Date Code Marking for SAT (Shanghai Assembly/ Test site)  $\overline{Y}M$  = Date Code Marking for CAT (Chengdu Assembly/ Test site)

Y or  $\overline{Y}$  = Year (ex: A = 2013) M = Month (ex: 9 = September)

Date Code Key

Year	201	1	2012		2013	20	14	2015		2016	2	2017
Code	Υ		Z		Α	[	3	С		D		Е
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



# Maximum Ratings (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Units	
Drain-Source Voltage	$V_{DSS}$	30	V		
Gate-Source Voltage	V <sub>GSS</sub>	±20	V		
		T <sub>A</sub> = +25°C T <sub>A</sub> = +70°C	I <sub>D</sub>	250 200	mA
Maximum Continuous Body Diode Forward Current	(Note 5)	Is	0.5	Α	
Pulsed Drain Current (10µs pulse, duty cycle=1%)		I <sub>DM</sub>	0.8	А	

# Thermal Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

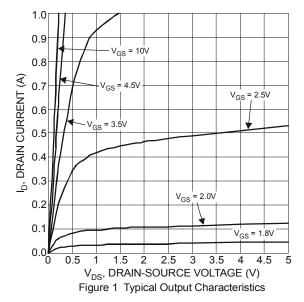
Characteristic		Symbol	Value	Units
Total Dawer Dissipation (Note 5)	T <sub>A</sub> = +25°C	T <sub>A</sub> = +25°C		W
Total Power Dissipation (Note 5)	T <sub>A</sub> = +70°C	P <sub>D</sub>	0.22	VV
Thermal Resistance, Junction to Ambient (Note 5)  Steady State		$R_{\theta JA}$	360	°C/M/
Thermal Resistance, Junction to Case	$R_{ heta JC}$	126	°C/W	
Operating and Storage Temperature Range	T <sub>J,</sub> T <sub>STG</sub>	-55 to 150	°C	

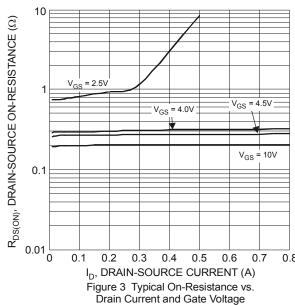
# **Electrical Characteristics** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

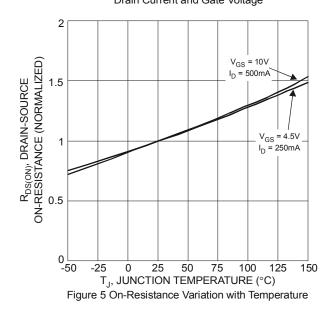
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 6)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	30	_	_	V	$V_{GS} = 0V$ , $I_D = 1mA$	
Zero Gate Voltage Drain Current @T <sub>C</sub> = +25°C	I <sub>DSS</sub>	_	_	1	μA	V <sub>DS</sub> = 30V, V <sub>GS</sub> = 0V	
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±10	μΑ	V <sub>GS</sub> = ±20V, V <sub>DS</sub> = 0V	
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage	V <sub>GS(th)</sub>	0.8	_	1.5	V	$V_{DS} = 3V, I_{D} = 100\mu A$	
		_	_	2.4		$V_{GS} = 10V, I_D = 250mA$	
		_	_	3.0		$V_{GS} = 4.5V, I_D = 250mA$	
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	_	_	5.0	Ω	$V_{GS} = 4.0V, I_D = 10mA$	
		_	_	7.0		$V_{GS} = 2.5V, I_D = 5mA$	
		_	_	20		$V_{GS} = 1.8V, I_D = 5mA$	
Forward Transfer Admittance	Y <sub>fs</sub>	10	_	-	mS	$V_{DS} = 3V, I_{D} = 10mA$	
Diode Forward Voltage	$V_{SD}$	_	_	1.2	V	V <sub>GS</sub> = 0V, I <sub>S</sub> = 115mA	
DYNAMIC CHARACTERISTICS (Note 7)							
Input Capacitance	C <sub>iss</sub>	_	48	_	pF	5///	
Output Capacitance	Coss	_	11	_	pF	$V_{DS} = 5V, V_{GS} = 0V,$ -f = 1.0MHz	
Reverse Transfer Capacitance	C <sub>rss</sub>	_	8	_	pF	1 = 1:0lvii iz	
Gate Resistance	$R_g$	_	57	_	Ω	f=1MHz , Vgs=0V, Vds=0V	
Total Gate Charge (V <sub>GS</sub> = 4.5V)	$Q_g$	_	0.55	_	nC		
Total Gate Charge (V <sub>GS</sub> = 10V)	Qq	_	1.23	_	nC	$V_{GS} = 10V, V_{DS} = 10V,$	
Gate-Source Charge	Q <sub>gs</sub>	_	0.14	_	nC	I <sub>D</sub> = 250mA	
Gate-Drain Charge	$Q_{gd}$	_	0.14	_	nC		
Turn-On Delay Time	t <sub>D(on)</sub>	_	2.9	_	ns		
Turn-On Rise Time		_	2.6	_	ns	V <sub>DD</sub> = 30V, V <sub>GS</sub> = 10V,	
Turn-Off Delay Time		_	18.2	_	ns	$R_G = 25\Omega$ , $I_D = 200mA$	
Turn-Off Fall Time		_	13.6	_	ns		

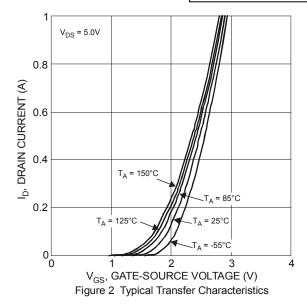
5. Device mounted on 1" x 1" FR-4 PCB with high coverage 2oz. Copper, single sided.
6. Short duration pulse test used to minimize self-heating effect.
7. Guaranteed by design. Not subject to product testing.

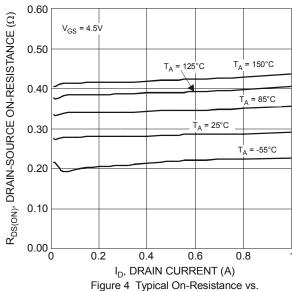


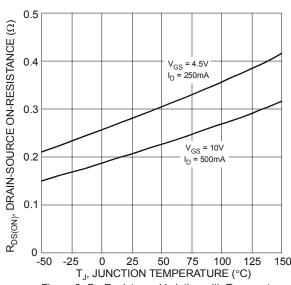












Drain Current and Temperature

Figure 6 On-Resistance Variation with Temperature



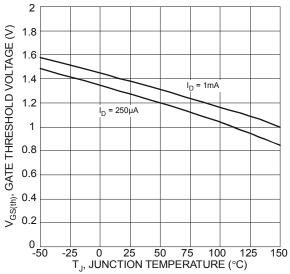
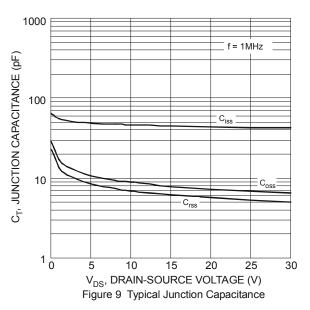
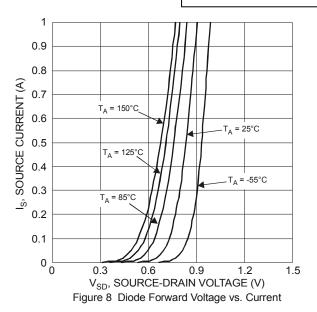
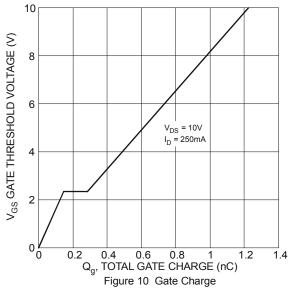
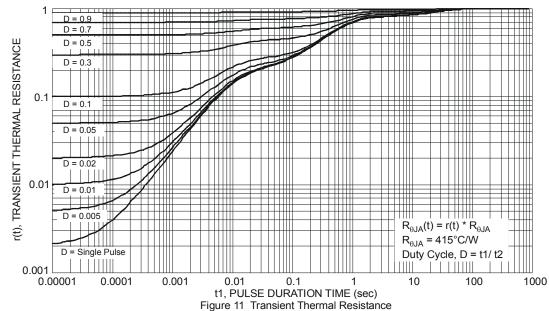


Figure 7 Gate Threshold Variation vs. Ambient Temperature





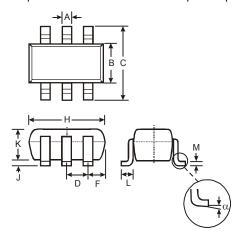






# **Package Outline Dimensions**

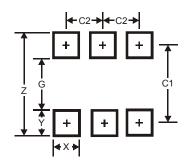
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



	SOT363						
Dim	Min Max Typ						
Α	0.10	0.30	0.25				
В	1.15	1.35	1.30				
C	2.00	2.20	2.10				
D	0.65 Typ						
F	0.40	0.45	0.425				
Н	1.80	2.20	2.15				
7	0	0.10	0.05				
K	0.90	1.00	1.00				
L	0.25	0.40	0.30				
М	0.10	0.22	0.11				
α	0°	8°	-				
All	All Dimensions in mm						

# **Suggested Pad Layout**

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
Z	2.5
G	1.3
X	0.42
Y	0.6
C1	1.9
C2	0.65



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